

Notice of References Cited

Application/Control No.

10/786,821

Applicant(s)/Patent Under
Reexamination
KIM ET AL.

Examiner

Quyen P. Leung

Art Unit

2874

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,287,293	02-1994	Chen et al.	702/40
*	B	US-5,103,304	04-1992	Turcheck et al.	348/130
*	C	US-4,978,195	12-1990	Takano et al.	385/116
*	D	US-4,672,437	06-1987	Casper, Lawrence A.	385/116
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.